# Atmel - ATTINY461V-10PU Datasheet





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### Details

Product Status	Active
Core Processor	AVR
Core Size	8-Bit
Speed	10MHz
Connectivity	USI
Peripherals	Brown-out Detect/Reset, POR, PWM, WDT
Number of I/O	16
Program Memory Size	4KB (2K x 16)
Program Memory Type	FLASH
EEPROM Size	256 x 8
RAM Size	256 x 8
Voltage - Supply (Vcc/Vdd)	1.8V ~ 5.5V
Data Converters	A/D 11x10b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 85°C (TA)
Mounting Type	Through Hole
Package / Case	20-DIP (0.300", 7.62mm)
Supplier Device Package	20-PDIP
Purchase URL	https://www.e-xfl.com/product-detail/atmel/attiny461v-10pu

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In different addressing modes these address registers function as automatic increment and automatic decrement (see the instruction set reference for details).

# 4.5 Stack Pointer

The Stack is mainly used for storing temporary data, for storing local variables and for storing return addresses after interrupts and subroutine calls. The Stack Pointer Register always points to the top of the Stack. Note that the Stack is implemented as growing from higher memory locations to lower memory locations. This implies that a Stack PUSH command decreases the Stack Pointer.

The Stack Pointer points to the data SRAM Stack area where the Subroutine and Interrupt Stacks are located. This Stack space in the data SRAM must be defined by the program before any subroutine calls are executed or interrupts are enabled. The Stack Pointer must be set to point above 0x60. The Stack Pointer is decremented by one when data is pushed onto the Stack with the PUSH instruction, and it is decremented by two when the return address is pushed onto the Stack with subroutine call or interrupt. The Stack Pointer is incremented by one when data is popped from the Stack with the POP instruction, and it is incremented by two when data is popped from the Stack with return from subroutine RET or return from interrupt RETI.

The AVR Stack Pointer is implemented as two 8-bit registers in the I/O space. The number of bits actually used is implementation dependent. Note that the data space in some implementations of the AVR architecture is so small that only SPL is needed. In this case, the SPH Register will not be present

Bit	15	14	13	12	11	10	9	8	
0x3E (0x5E)	SP15	SP14	SP13	SP12	SP11	SP10	SP9	SP8	SPH
0x3D (0x5D)	SP7	SP6	SP5	SP4	SP3	SP2	SP1	SP0	SPL
	7	6	5	4	3	2	1	0	-
Read/Write	R/W								
	R/W								
Initial Value	RAMEND								
	RAMEND								

# 4.5.1 SPH and SPL — Stack Pointer Register

# 4.6 Instruction Execution Timing

This section describes the general access timing concepts for instruction execution. The AVR CPU is driven by the CPU clock clk<sub>CPU</sub>, directly generated from the selected clock source for the chip. No internal clock division is used.

Figure 4-4 shows the parallel instruction fetches and instruction executions enabled by the Harvard architecture and the fast access Register File concept. This is the basic pipelining concept to obtain up to 1 MIPS per MHz with the corresponding unique results for functions per cost, functions per clocks, and functions per power-unit.



# 5.5.2 EEARL – EEPROM Address Register

Bit	7	6	5	4	3	2	1	0	_
0x1E (0x3E)	EEAR7	EEAR6	EEAR5	EEAR4	EEAR3	EEAR2	EEAR1	EEAR0	EEARL
Read/Write	R/W	•							
Initial Value	X/0	Х	Х	Х	Х	Х	Х	Х	

# • Bit 7 – EEAR7: EEPROM Address

This is the most significant EEPROM address bit of ATtiny461. In devices with less EEPROM, i.e. ATtiny261, this bit is reserved and will always read zero. The initial value of the EEPROM Address Register (EEAR) is undefined and a proper value must therefore be written before the EEPROM is accessed.

# Bits 6:0 – EEAR6:0: EEPROM Address

These are the (low) bits of the EEPROM Address Register. The EEPROM data bytes are addressed linearly in the range 0...128/256/512. The initial value of EEAR is undefined and a proper value must be therefore be written before the EEPROM may be accessed.

# 5.5.3 EEDR – EEPROM Data Register

Bit	7	6	5	4	3	2	1	0	_
0x1D (0x3D)	EEDR7	EEDR6	EEDR5	EEDR4	EEDR3	EEDR2	EEDR1	EEDR0	EEDR
Read/Write	R/W	-							
Initial Value	0	0	0	0	0	0	0	0	

# • Bits 7:0 – EEDR7:0: EEPROM Data

For the EEPROM write operation the EEDR Register contains the data to be written to the EEPROM in the address given by the EEAR Register. For the EEPROM read operation, the EEDR contains the data read out from the EEPROM at the address given by EEAR.

# 5.5.4 EECR – EEPROM Control Register

Bit	7	6	5	4	3	2	1	0	_
0x1C (0x3C)	-	-	EEPM1	EEPM0	EERIE	EEMPE	EEPE	EERE	EECR
Read/Write	R	R	R/W	R/W	R/W	R/W	R/W	R/W	-
Initial Value	0	0	Х	Х	0	0	Х	0	

# • Bit 7 - Res: Reserved Bit

This bit is reserved for future use and will always read as 0 in ATtiny261/461/861. For compatibility with future AVR devices, always write this bit to zero. After reading, mask out this bit.

# • Bit 6 - Res: Reserved Bit

This bit is reserved in the ATtiny261/461/861 and will always read as zero.

# • Bits 5, 4 – EEPM1 and EEPM0: EEPROM Programming Mode Bits

The EEPROM Programming mode bits setting defines which programming action that will be triggered when writing EEPE. It is possible to program data in one atomic operation (erase the

# 5.5.6 GPIOR1 – General Purpose I/O Register 1



# 5.5.7 GPIOR0 – General Purpose I/O Register 0

Bit	7	6	5	4	3	2	1	0	
0x0A (0x2A)	MSB							LSB	GPIOR0
Read/Write	R/W	-							
Initial Value	0	0	0	0	0	0	0	0	

mencing normal operation. The watchdog oscillator is used for timing this real-time part of the start-up time. The number of WD oscillator cycles used for each time-out is shown in Table 6-2.

 Table 6-2.
 Number of Watchdog Oscillator Cycles

Typ Time-out	Number of Cycles
4 ms	512
64 ms	8K (8,192)

### 6.2.1 External Clock

To drive the device from an external clock source, CLKI should be driven as shown in Figure 6-2. To run the device on an external clock, the CKSEL Fuses must be programmed to "0000".

Figure 6-2. External Clock Drive Configuration



When this clock source is selected, start-up times are determined by the SUT Fuses as shown in Table 6-3.

Table 6-3. S	Start-up Times	for the External	<b>Clock Selection</b>
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SUT1:0	Start-up Time from Power- down and Power-save	Additional Delay from Reset	Recommended Usage
00	6 CK	14CK	BOD enabled
01	6 CK	14CK + 4 ms	Fast rising power
10	6 CK	14CK + 64 ms	Slowly rising power
11		Reserved	

When applying an external clock, it is required to avoid sudden changes in the applied clock frequency to ensure stable operation of the MCU. A variation in frequency of more than 2% from one clock cycle to the next can lead to unpredictable behavior. It is required to ensure that the MCU is kept in Reset during such changes in the clock frequency.

Note that the system clock prescaler can be used to implement run-time changes of the internal clock frequency. See "System Clock Prescaler" on page 31 for details.

# 6.2.2 High-Frequency PLL Clock

The internal PLL generates a clock signal with a frequency eight times higher than the source input. The PLL uses the output of the internal 8 MHz oscillator as source and the default setting generates a fast peripheral clock signal of 64 MHz.

# 7. Power Management and Sleep Modes

The high performance and industry leading code efficiency makes the AVR microcontrollers an ideal choise for low power applications. In addition, sleep modes enable the application to shut down unused modules in the MCU, thereby saving power. The AVR provides various sleep modes allowing the user to tailor the power consumption to the application's requirements.

# 7.1 Sleep Modes

Figure 6-1 on page 24 presents the different clock systems and their distribution in ATtiny261/461/861. The figure is helpful in selecting an appropriate sleep mode. Table 7-1 shows the different sleep modes and their wake up sources.

Active Clock Domains					าร	Osc.	Osc. Wake-up Sources						
Sleep Mode	clk <sub>GPU</sub>	clk <sub>FLASH</sub>	clk <sub>IO</sub>	clk <sub>ADC</sub>	clk <sub>PCK</sub>	clk <sub>PLL</sub>	Main Clock Source Enabled	INT0, INT1 and Pin Change	SPM/EEPROM Ready Interrupt	ADC Interrupt	USI Interrupt	Other I/O	Watchdog Interrupt
Idle			Х	Х	Х	X <sup>(2)</sup>	Х	Х	Х	Х	Х	Х	Х
ADC Noise Reduct.				Х		X <sup>(2)</sup>	Х	X <sup>(1)</sup>	Х	Х	Х		Х
Power-down								X <sup>(1)</sup>			Х		Х
Standby								X <sup>(1)</sup>			Х		Х

 Table 7-1.
 Active Clock Domains and Wake-up Sources in Different Sleep Modes

Note: 1. For INT0 and INT1, only level interrupt.

2. When PLL selected as system clock.

To enter any of the sleep modes, the SE bit in MCUCR must be written to logic one and a SLEEP instruction must be executed. The SM1:0 bits in the MCUCR Register select which sleep mode (Idle, ADC Noise Reduction, Power-down, or Standby) will be activated by the SLEEP instruction. See Table 7-2 for a summary.

If an enabled interrupt occurs while the MCU is in a sleep mode, the MCU wakes up. The MCU is then halted for four cycles in addition to the start-up time, executes the interrupt routine, and resumes execution from the instruction following SLEEP. The contents of the Register File and SRAM are unaltered when the device wakes up from sleep. If a reset occurs during sleep mode, the MCU wakes up and executes from the Reset Vector.

Note that if a level triggered interrupt is used for wake-up the changed level must be held for some time to wake up the MCU (and for the MCU to enter the interrupt service routine). See "External Interrupts" on page 51 for details.

# 7.1.1 Idle Mode

When bits SM1:0 are written to 00, the SLEEP instruction makes the MCU enter Idle mode, stopping the CPU but allowing Analog Comparator, ADC, Timer/Counter, Watchdog, and the interrupt system to continue operating. This sleep mode basically halts clk<sub>CPU</sub> and clk<sub>FLASH</sub>, while allowing the other clocks to run.

# 10.1 Ports as General Digital I/O

The ports are bi-directional I/O ports with optional internal pull-ups. Figure 10-2 shows a functional description of one I/O-port pin, here generically called Pxn.



Figure 10-2. General Digital I/O<sup>(1)</sup>



# 10.1.1 Configuring the Pin

Each port pin consists of three register bits: DDxn, PORTxn, and PINxn. As shown in "Register Description" on page 69, the DDxn bits are accessed at the DDRx I/O address, the PORTxn bits at the PORTx I/O address, and the PINxn bits at the PINx I/O address.

The DDxn bit in the DDRx Register selects the direction of this pin. If DDxn is written logic one, Pxn is configured as an output pin. If DDxn is written logic zero, Pxn is configured as an input pin.

If PORTxn is written logic one when the pin is configured as an input pin, the pull-up resistor is activated. To switch the pull-up resistor off, PORTxn has to be written logic zero or the pin has to

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# • Port A, Bit 5 – ADC4/AIN2/PCINT5

- ADC4: Analog to Digital Converter, Channel 4.
- AIN2: Analog Comparator Input. Configure the port pin as input with the internal pull-up switched off to avoid the digital port function from interfering with the function of the Analog Comparator.
- PCINT5: Pin Change Interrupt source 5.

# • Port A, Bit 4 – ADC3/ICP0/PCINT4

- ADC3: Analog to Digital Converter, Channel 3.
- ICP0: Timer/Counter0 Input Capture Pin.
- PCINT4: Pin Change Interrupt source 4.

# • Port A, Bit 3 – AREF/PCINT3

- AREF: External analog reference for ADC. Pullup and output driver are disabled on PA3 when the pin is used as an external reference or internal voltage reference with external capacitor at the AREF pin.
- PCINT3: Pin Change Interrupt source 3.

# • Port A, Bit 2 – ADC2/INT1/USCK/SCL/PCINT2

- ADC2: Analog to Digital Converter, Channel 2.
- INT1: The PA2 pin can serve as an External Interrupt source 1.
- USCK: Three-wire mode Universal Serial Interface Clock.
- SCL: Two-wire mode Serial Clock for USI Two-wire mode.
- PCINT2: Pin Change Interrupt source 2.

# • Port A, Bit 1 – ADC1/DO/PCINT1

- ADC1: Analog to Digital Converter, Channel 1.
- DO: Three-wire mode Universal Serial Interface Data output. Three-wire mode Data output overrides PORTA1 value and it is driven to the port when data direction bit DDA1 is set. PORTA1 still enables the pull-up, if the direction is input and PORTA1 is set.
- PCINT1: Pin Change Interrupt source 1.

# Port A, Bit 0 – ADC0/DI/SDA/PCINT0

- ADC0: Analog to Digital Converter, Channel 0.
- DI: Data Input in USI Three-wire mode. USI Three-wire mode does not override normal port functions, so pin must be configure as an input for DI function.
- SDA: Two-wire mode Serial Interface Data.
- PCINT0: Pin Change Interrupt source 0.

visible in the Timer Interrupt Flag Register (TIFR). All interrupts are individually masked with the Timer Interrupt Mask Register (TIMSK). TIFR and TIMSK are not shown in the figure.

In 16-bit mode one more 8-bit register is available, the Timer/Counter0 High Byte Register (TCNT0H). Also, in 16-bit mode, there is only one output compare unit as the two Output Compare Registers, OCR0A and OCR0B, are combined to one, 16-bit Output Compare Register, where OCR0A contains the low byte and OCR0B contains the high byte of the word. When accessing 16-bit registers, special procedures described in section "Accessing Registers in 16-bit Mode" on page 80 must be followed.

# 11.2.2 Definitions

Many register and bit references in this section are written in general form. A lower case "n" replaces the Timer/Counter number, in this case 0. A lower case "x" replaces the Output Compare Unit, in this case Compare Unit A or Compare Unit B. However, when using the register or bit defines in a program, the precise form must be used, i.e. TCNT0L for accessing Timer/Counter0 counter value, and so on.

The definitions in Table 11-1 are also used extensively throughout the document.

	Definitions
Constant	Description
BOTTOM	The counter reaches BOTTOM when it becomes 0x00
MAX	The counter reaches its MAXimum when it becomes 0xFF (decimal 255)
TOP	The counter reaches the TOP when it becomes equal to the highest value in the count sequence. The TOP value can be assigned to be the fixed value 0xFF (MAX) or the value stored in the OCR0A Register. The assignment depends on the mode of operation

Table 11-1.Definitions

# 11.3 Clock Sources

The Timer/Counter can be clocked internally, via the prescaler, or by an external clock source on the T0 pin. The Clock Select logic is controlled by the Clock Select (CS02:0) bits located in the Timer/Counter Control Register 0 B (TCCR0B), and controls which clock source and edge the Timer/Counter uses to increment its value. The Timer/Counter is inactive when no clock source is selected. The output from the Clock Select logic is referred to as the timer clock ( $clk_{T0}$ ).

# 11.3.1 Prescaler

The Timer/Counter can be clocked directly by the system clock (by setting the CSn2:0 = 1). This provides the fastest operation, with a maximum Timer/Counter clock frequency equal to system clock frequency ( $f_{CLK_{-}I/O}$ ). Alternatively, one of four taps from the prescaler can be used as a clock source.

See Figure 11-2 for an illustration of the prescaler unit.

# Figure 11-3. T0 Pin Sampling



The synchronization and edge detector logic introduces a delay of 2.5 to 3.5 system clock cycles from an edge has been applied to the T0 pin to the counter is updated.

Enabling and disabling of the clock input must be done when T0 has been stable for at least one system clock cycle, otherwise it is a risk that a false Timer/Counter clock pulse is generated.

Each half period of the external clock applied must be longer than one system clock cycle to ensure correct sampling. The external clock must be guaranteed to have less than half the system clock frequency ( $f_{ExtClk} < f_{clk_l/O}/2$ ) given a 50/50% duty cycle. Since the edge detector uses sampling, the maximum frequency of an external clock it can detect is half the sampling frequency (Nyquist sampling theorem). However, due to variation of the system clock frequency and duty cycle caused by Oscillator source (crystal, resonator, and capacitors) tolerances, it is recommended that maximum frequency of an external clock source is less than  $f_{clk_l/O}/2.5$ .

An external clock source can not be prescaled.

# 11.4 Counter Unit

The main part of the 8-bit Timer/Counter is the programmable bi-directional counter unit. Figure 11-4 shows a block diagram of the counter and its surroundings.



 Table 11-2.
 Counter Unit Block Diagram

Signal description (internal signals):

count	Increment or decrement TCNT0 by 1.
clk <sub>Tn</sub>	Timer/Counter clock, referred to as $clk_{T0}$ in the following.
top	Signalize that TCNT0 has reached maximum value.

The counter is incremented at each timer clock  $(clk_{T0})$  until it passes its TOP value and then restarts from BOTTOM. The counting sequence is determined by the setting of the CTC0 bit located in the Timer/Counter Control Register (TCCR0A). For more details about counting sequences, see "Modes of Operation" on page 77.  $clk_{T0}$  can be generated from an external or

internal clock source, selected by the Clock Select bits (CS02:0). When no clock source is selected (CS02:0 = 0) the timer is stopped. However, the TCNT0 value can be accessed by the CPU, regardless of whether  $clk_{T0}$  is present or not. A CPU write overrides (has priority over) all counter clear or count operations. The Timer/Counter Overflow Flag (TOV0) is set when the counter reaches the maximum value and it can be used for generating a CPU interrupt.

# 11.5 Input Capture Unit

The Timer/Counter incorporates an Input Capture unit that can capture external events and give them a time-stamp indicating time of occurrence. The external signal indicating an event, or multiple events, can be applied via the ICP0 pin or alternatively, via the analog-comparator unit. The time-stamps can then be used to calculate frequency, duty-cycle, and other features of the signal applied. Alternatively the time-stamps can be used for creating a log of the events.

The Input Capture unit is illustrated by the block diagram shown in Figure 11-4. The elements of the block diagram that are not directly a part of the Input Capture unit are gray shaded.



Figure 11-4. Input Capture Unit Block Diagram

The Output Compare Register OCR0A is a dual-purpose register that is also used as an 8-bit Input Capture Register ICR0. In 16-bit Input Capture mode the Output Compare Register OCR0B serves as the high byte of the Input Capture Register ICR0. In 8-bit Input Capture mode the Output Compare Register OCR0B is free to be used as a normal Output Compare Register, but in 16-bit Input Capture mode the Output Compare Unit cannot be used as there are no free Output Compare Register(s). Even though the Input Capture register is called ICR0 in this section, it is refering to the Output Compare Register(s).

When a change of the logic level (an event) occurs on the *Input Capture pin* (ICP0), alternatively on the *Analog Comparator output* (ACO), and this change confirms to the setting of the edge detector, a capture will be triggered. When a capture is triggered, the value of the counter (TCNT0) is written to the *Input Capture Register* (ICR0). The *Input Capture Flag* (ICF0) is set at

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actual value from the port register will be visible on the port pin. The configurations of the Output Compare Pins are described in Table 12-4.

COM1x1	COM1x0	OC1x Pin	OC1x Pin
0	0	Disconnected	Disconnected
0	1	OC1x	OC1x
1	0	Disconnected	OC1x
1	1	Disconnected	OC1x

 Table 12-4.
 Output Compare pin configurations in Phase and Frequency Correct PWM Mode

# 12.8.4 PWM6 Mode

The PWM6 Mode (PWM1A = 1, WGM11:10 = 1X) provide PWM waveform generation option e.g. for controlling Brushless DC (BLDC) motors. In the PWM6 Mode the OCR1A Register controls all six Output Compare waveforms as the same Waveform Output (OCW1A) from the Waform Generator is used for generating all waveforms. The PWM6 Mode also provides an Output Compare Override Enable Register (OC1OE) that can be used with an instant response for disabling or enabling the Output Compare pins. If the Output Compare Override Enable bit is cleared, the actual value from the port register will be visible on the port pin.

The PWM6 Mode provides two counter operation modes, a single-slope operation and a dualslope operation. If the single-slope operation is selected (the WGM10 bit is set to 0), the counter counts from BOTTOM to TOP (defined as OCR1C) then restart from BOTTOM like in Fast PWM Mode. The PWM waveform is generated by setting (or clearing) the Waveforn Output (OCW1A) at the Compare Match between OCR1A and TCNT1, and clearing (or setting) the Waveform Output at the timer clock cycle the counter is cleared (changes from TOP to BOTTOM). The Timer/Counter Overflow Flag (TOV1) is set each time the counter reaches the TOP and, if the interrupt is enabled, the interrupt handler routine can be used for updating the compare value.

Whereas, if the dual-slope operation is selected (the WGM10 bit is set to 1), the counter counts repeatedly from BOTTOM to TOP (defined as OCR1C) and then from TOP to BOTTOM like in Phase and Frequency Correct PWM Mode. The PWM waveform is generated by setting (or clearing) the Waveforn Output (OCW1A) at the Compare Match between OCR1A and TCNT1 when the counter increments, and clearing (or setting) the Waveform Output at the he Compare Match between OCR1A and TCNT1 when the counter decrements. The Timer/Counter Overflow Flag (TOV1) is set each time the counter reaches the BOTTOM and, if the interrupt is enabled, the interrupt handler routine can be used for updating the compare value.

The timing diagram for the PWM6 Mode in single-slope operation when the COM1A1:0 bits are set to "10" is shown in Figure 12-14. The counter is incremented until the counter value matches the TOP value. The counter is then cleared at the following timer clock cycle. The TCNT1 value is in the timing diagram shown as a histogram for illustrating the single-slope operation. The timing diagram includes Output Compare pins OC1A and OC1A, and the corresponding Output Compare Override Enable bits (OC1OE1:OC1OE0).

# • Bits 1, 0 – ACIS1, ACIS0: Analog Comparator Interrupt Mode Select

These bits determine which comparator events that trigger the Analog Comparator interrupt. The different settings are shown in Table 14-2.

Table 14-2.ACIS1/ACIS0 Settings

ACIS1	ACIS0	Interrupt Mode
0	0	Comparator Interrupt on Output Toggle.
0	1	Reserved
1	0	Comparator Interrupt on Falling Output Edge.
1	1	Comparator Interrupt on Rising Output Edge.

When changing the ACIS1/ACIS0 bits, the Analog Comparator Interrupt must be disabled by clearing its Interrupt Enable bit in the ACSR Register. Otherwise an interrupt can occur when the bits are changed.

# 14.2.2 ACSRB – Analog Comparator Control and Status Register B



# • Bit 7 – HSEL: Hysteresis Select

When this bit is written logic one, the hysteresis of the Analog Comparator is switched on. The hysteresis level is selected by the HLEV bit.

# • Bit 6 – HLEV: Hysteresis Level

When the hysteresis is enabled by the HSEL bit, the Hysteresis Level, HLEV, bit selects the hysteresis level that is either 20mV (HLEV=0) or 50mV (HLEV=1).

# • Bits 2:0 – ACM2:ACM0: Analog Comparator Multiplexer

The Analog Comparator multiplexer bits select the positive and negative input pins of the Analog Comparator. The different settings are shown in Table 14-1.

# 14.2.3 DIDR0 – Digital Input Disable Register 0

Bit	7	6	5	4	3	2	1	0	_
0x01 (0x21)	ADC6D	ADC5D	ADC4D	ADC3D	AREFD	ADC2D	ADC1D	ADC0D	DIDR0
Read/Write	R/W	•							
Initial Value	0	0	0	0	0	0	0	0	

# • Bits 7:4,2:0 - ADC6D:ADC0D: ADC6:0 Digital Input Disable

When this bit is written logic one, the digital input buffer on the corresponding ADC pin is disabled. The corresponding PIN register bit will always read as zero when this bit is set. When an analog signal is applied to the ADC7:0 pin and the digital input from this pin is not needed, this bit should be written logic one to reduce power consumption in the digital input buffer.

# • Bit 3 – AREFD: AREF Digital Input Disable

When this bit is written logic one, the digital input buffer on the AREF pin is disabled. The corresponding PIN register bit will always read as zero when this bit is set. When an analog signal is



Figure 15-7. ADC Timing Diagram, Free Running Conversion

For a summary of conversion times, see Table 15-1.

Table 15-1.ADC Conversion Time

Condition	Sample & Hold (Cycles from Start of Conversion)	Total Conversion Time (Cycles)	
First conversion	13.5	25	
Normal conversions	1.5	13	
Auto Triggered conversions	2	13.5	

# 15.6 Changing Channel or Reference Selection

The MUX5:0 and REFS2:0 bits in the ADCSRB and ADMUX registers are single buffered through a temporary register to which the CPU has random access. This ensures that the channels and reference selection only takes place at a safe point during the conversion. The channel and reference selection is continuously updated until a conversion is started. Once the conversion starts, the channel and reference selection is locked to ensure a sufficient sampling time for the ADC. Continuous updating resumes in the last ADC clock cycle before the conversion completes (ADIF in ADCSRA is set). Note that the conversion starts on the following rising ADC clock edge after ADSC is written. The user is thus advised not to write new channel or reference selection values to ADMUX until one ADC clock cycle after ADSC is written.

If Auto Triggering is used, the exact time of the triggering event can be indeterministic. Special care must be taken when updating the ADMUX Register, in order to control which conversion will be affected by the new settings.

If both ADATE and ADEN is written to one, an interrupt event can occur at any time. If the ADMUX Register is changed in this period, the user cannot tell if the next conversion is based on the old or the new settings.

ADMUX can be safely updated in the following ways:

gain stage enables offset measurements. Selecting the single-ended channel ADC11 enables the temperature sensor. Refer to Table 15-4 for details.

	Single-Ended	Differen			
MUX5:0	Input	Positive	Negative	Gain	
000000	ADC0 (PA0)				
000001	ADC1 (PA1)				
000010	ADC2 (PA2)				
000011	ADC3 (PA4)				
000100	ADC4 (PA5)			NA	
000101	ADC5 (PA6)	NA	NA		
000110	ADC6 (PA7)				
000111	ADC7 (PB4)				
001000	ADC8 (PB5)				
001001	ADC9 (PB6)				
001010	ADC10 (PB7)				
001011		ADC0 (PA0)	ADC1 (PA1)	20x	
001100		ADC0 (PA0)	ADC1 (PA1)	1x	
001101	NA	ADC1 (PA1)	ADC1 (PA1)	20x	
001110		ADC2 (PA2)	ADC1 (PA1)	20x	
001111		ADC2 (PA2)	ADC1 (PA1)	1x	
010000		ADC2 (PA2)	ADC3 (PA4)	1x	
010001	N1/A	ADC3 (PA4)	ADC3 (PA4)	20x	
010010	IN/A	ADC4 (PA5)	ADC3 (PA4)	20x	
010011		ADC4 (PA5)	ADC3 (PA4)	1x	
010100		ADC4 (PA5)	ADC5 (PA6)	20x	
010101		ADC4 (PA5)	ADC5 (PA6)	1x	
010110	NA	ADC5 (PA6)	ADC5 (PA6)	20x	
010111		ADC6 (PA7)	ADC5 (PA6)	20x	
011000		ADC6 (PA7)	ADC5 (PA6)	1x	
011001		ADC8 (PB5)	ADC9 (PB6)	20x	
011010		ADC8 (PB5)	ADC9 (PB6)	1x	
011011	NA	ADC9 (PB6)	ADC9 (PB6)	20x	
011100		ADC10 (PB7)	ADC9 (PB6)	20x	
011101		ADC10 (PB7)	ADC9 (PB6)	1x	
011110	1.1V	N1/A	N1/A	N1/A	
011111	0V	IN/A	IN/A	IN/A	

Table 15-4. Input Channel Selections

# **19. Electrical Characteristics**

# 19.1 Absolute Maximum Ratings\*

Operating Temperature55°C to +125°C
Storage Temperature65°C to +150°C
Voltage on any Pin except $\overline{\mbox{RESET}}$ with respect to Ground0.5V to V $_{\rm CC}$ +0.5V
Voltage on $\overline{\text{RESET}}$ with respect to Ground0.5V to +13.0V
Maximum Operating Voltage6.0V
DC Current per I/O Pin 40.0 mA
DC Current $V_{CC}$ and GND Pins

\*NOTICE: Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or other conditions beyond those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

# 19.2 DC Characteristics

Table 19-1.	DC Characteristics.	$T_{A} = -40^{\circ}C \text{ to } +85^{\circ}C, $	$V_{\rm CC} = 1.8 V$ to 5.5 V	(unless otherwise noted).
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Symbol	Parameter	Condition	Min	<b>Typ</b> <sup>(1)</sup>	Max	Units
V <sub>IL</sub>	Input Low-voltage	Except XTAL1 and RESET pins	-0.5		0.2V <sub>CC</sub> <sup>(3)</sup>	V
		XTAL1 pin, External Clock Selected	-0.5		0.1V <sub>CC</sub> <sup>(3)</sup>	V
		RESET pin	-0.5		0.2V <sub>CC</sub> <sup>(3)</sup>	V
		RESET pin as I/O	-0.5		0.2V <sub>CC</sub> <sup>(3)</sup>	V
	Input High-voltage	Except XTAL1 and RESET pins	0.7V <sub>CC</sub> <sup>(2)</sup>		V <sub>CC</sub> +0.5	V
V <sub>IH</sub>		XTAL1 pin, External Clock Selected	0.8V <sub>CC</sub> <sup>(2)</sup>		V <sub>CC</sub> +0.5	V
		RESET pin	0.9V <sub>CC</sub> <sup>(2)</sup>		V <sub>CC</sub> +0.5	V
		RESET pin as I/O	0.7V <sub>CC</sub> <sup>(2)</sup>		V <sub>CC</sub> +0.5	V
V <sub>OL</sub>	Output Low Voltage <sup>(4)</sup> (Except Reset pin) <sup>(6)</sup>	$I_{OL} = 10 \text{ mA}, V_{CC} = 5V$ $I_{OL} = 5 \text{ mA}, V_{CC} = 3V$			0.6 0.5	V V
V <sub>OH</sub>	Output High-voltage <sup>(5)</sup> (Except Reset pin) <sup>(6)</sup>	$I_{OH} = -10 \text{ mA}, V_{CC} = 5V$ $I_{OH} = -5 \text{ mA}, V_{CC} = 3V$	4.3 2.5			V V
IIL	Input Leakage Current I/O Pin	Vcc = 5.5V, pin low (absolute value)		< 0.05	1	μA
I <sub>IH</sub>	Input Leakage Current I/O Pin	Vcc = 5.5V, pin high (absolute value)		< 0.05	1	μA
R <sub>RST</sub>	Reset Pull-up Resistor		30		60	kΩ
R <sub>PU</sub>	I/O Pin Pull-up Resistor		20		50	kΩ

# 20.3 Idle Supply Current



Figure 20-6. Idle Supply Current vs. Low Frequency (0.1 - 1.0 MHz) IDLE SUPPLY CURRENT vs. LOW FREQUENCY







# Figure 20-10. Idle Supply Current vs. V<sub>CC</sub> (Internal RC Oscillator, 128 kHz)

# 20.4 Power-down Supply Current



Figure 20-46. Watchdog Timer Current vs. V<sub>CC</sub>

WATCHDOG TIMER CURRENT vs. V<sub>CC</sub>



# 20.11 Current Consumption in Reset and Reset Pulsewidth





- "Reset Pin Output Voltage vs. Sink Current (VCC = 3V)" on page 209
- "Reset Pin Output Voltage vs. Sink Current (VCC = 3V)" on page 209
- "Reset Pin Output Voltage vs. Sink Current (VCC = 3V)" on page 209
- "Reset Pin Output Voltage vs. Sink Current (VCC = 3V)" on page 209
- "Bandgap Voltage vs. Supply Voltage (VCC)." on page 216
- 6. Updated Figures:
  - "Block Diagram" on page 4
  - "Clock Distribution" on page 24
- 7. Added Table:
  - "Capacitance for Low-Frequency Crystal Oscillator" on page 29
- 8. Updated Tables:
  - "Start-up Times for the Internal Calibrated RC Oscillator Clock Selection" on page 28
  - "Start-up Times for the 128 kHz Internal Oscillator" on page 29
  - "Active Clock Domains and Wake-up Sources in Different Sleep Modes" on page 36
  - "Serial Programming Characteristics, TA = -40°C to +85°C, VCC = 1.8 5.5V (Unless Otherwise Noted)" on page 193
- 9. Updated Register Descriptions:
  - "TCCR1A Timer/Counter1 Control Register A" on page 112
  - "TCCR1C Timer/Counter1 Control Register C" on page 117
  - "ADMUX ADC Multiplexer Selection Register" on page 155
- 10. Updated assembly program example in section "Write" on page 17.
- 11. Updated "DC Characteristics. TA = -40°C to +85°C, VCC = 1.8V to 5.5V (unless otherwise noted)." on page 187.

# 26.5 Rev. 2588B - 11/06

- 1. Updated "Ordering Information" on page 227.
- 2. Updated "Packaging Information" on page 231.

# 26.6 Rev. 2588A - 10/06

1. Initial Revision.

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